

Search Notes

Application/Control No.

10/714,684

Examiner

W. Patty Chen

Applicant(s)/Patent under
Reexamination

YOSHIDA ET AL.

Art Unit

2871

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
349/117-120 combined with key words search of all databases in EAST	12/21/2007	WPC
citations search of relevant references	12/21/2007	WPC